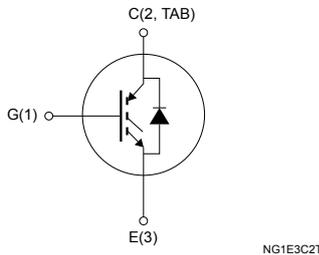
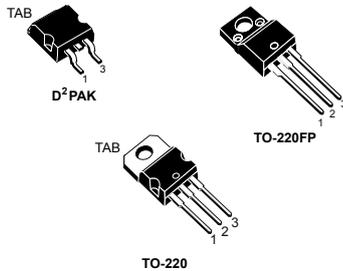




Trench gate field-stop 600 V, 10 A high speed H series IGBT



Features

- High speed switching
- Tight parameters distribution
- Safe paralleling
- Low thermal resistance
- Short-circuit rated
- Ultrafast soft recovery antiparallel diode

Applications

- Motor control
- UPS
- PFC

Description

These devices are IGBTs developed using an advanced proprietary trench gate field-stop structure. These devices are part of the H series of IGBTs, which represents an optimum compromise between conduction and switching losses to maximize the efficiency of high switching frequency converters. Furthermore, a slightly positive $V_{CE(sat)}$ temperature coefficient and very tight parameter distribution result in safer paralleling operation.



Product status link

[STGB10H60DF](#)

[STGF10H60DF](#)

[STGP10H60DF](#)

1 Electrical ratings

Table 1. Absolute maximum ratings

Symbol	Parameter	Value		Unit
		D ² PAK, TO-220	TO-220FP	
V _{CES}	Collector-emitter voltage (V _{GE} = 0 V)	600		V
I _C	Continuous collector current at T _C = 25 °C	20	20 ⁽¹⁾	A
	Continuous collector current at T _C = 100 °C	10	10 ⁽¹⁾	
I _{CP} ⁽²⁾	Pulsed collector current	40	40	A
V _{GE}	Gate-emitter voltage	±20		V
	Transient gate-emitter voltage	±30		
I _F	Continuous forward current at T _C = 25 °C	20	20 ⁽¹⁾	A
	Continuous forward current at T _C = 100 °C	10	10 ⁽¹⁾	
I _{FP} ⁽²⁾	Pulsed forward current	40	40	A
V _{ISO}	Insulation withstand voltage (RMS) from all three leads to external heat sink (t = 1 s; T _C = 25 °C)		2.5	kV
P _{TOT}	Total power dissipation at T _C = 25 °C	115	30	W
T _{STG}	Storage temperature range	-55 to 150		°C
T _J	Operating junction temperature range	-55 to 175		

1. Limited by maximum junction temperature.
2. Pulse width limited by maximum junction temperature.

Table 2. Thermal data

Symbol	Parameter	Value		Unit
		D ² PAK, TO-220	TO-220FP	
R _{thJC}	Thermal resistance, junction-to-case IGBT	1.3	5	°C/W
R _{thJC}	Thermal resistance, junction-to-case diode	2.78	6.25	°C/W
R _{thJA}	Thermal resistance, junction-to-ambient	62.5	62.5	°C/W

2 Electrical characteristics

$T_C = 25\text{ °C}$ unless otherwise specified.

Table 3. Static

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$V_{(BR)CES}$	Collector-emitter breakdown voltage	$V_{GE} = 0\text{ V}$, $I_C = 2\text{ mA}$	600			V
$V_{CE(sat)}$	Collector-emitter saturation voltage	$V_{GE} = 15\text{ V}$, $I_C = 10\text{ A}$		1.50	1.95	V
		$V_{GE} = 15\text{ V}$, $I_C = 10\text{ A}$, $T_J = 125\text{ °C}$		1.65		
		$V_{GE} = 15\text{ V}$, $I_C = 10\text{ A}$, $T_J = 175\text{ °C}$		1.70		
$V_{GE(th)}$	Gate threshold voltage	$V_{CE} = V_{GE}$, $I_C = 250\text{ }\mu\text{A}$	5	6	7	V
I_{CES}	Collector cut-off current	$V_{CE} = 600\text{ V}$, $V_{GE} = 0\text{ V}$			25	μA
I_{GES}	Gate-emitter leakage current	$V_{GE} = \pm 20\text{ V}$, $V_{CE} = 0\text{ V}$			± 250	nA

Table 4. Dynamic

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
C_{ies}	Input capacitance	$V_{CE} = 25\text{ V}$, $f = 1\text{ MHz}$, $V_{GE} = 0\text{ V}$	-	1300	-	μF
C_{oes}	Output capacitance			60		
C_{res}	Reverse transfer capacitance			30		
Q_g	Total gate charge	$V_{CC} = 480\text{ V}$, $I_C = 10\text{ A}$, $V_{GE} = 0\text{ to }15\text{ V}$ (see Figure 35. Gate charge test circuit)	-	57	-	nC
Q_{ge}	Gate-emitter charge			8		
Q_{gc}	Gate-collector charge			27		

Table 5. Switching characteristics (inductive load)

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$t_{d(on)}$	Turn-on delay time	$V_{CE} = 400\text{ V}$, $I_C = 10\text{ A}$, $R_G = 10\ \Omega$,		19.5		ns
t_r	Current rise time	$V_{GE} = 15\text{ V}$		6.9		
$(di/dt)_{on}$	Turn-on current slope	(see Figure 34. Test circuit for inductive load switching and Figure 36. Switching waveform)		1170		
$t_{d(on)}$	Turn-on delay time	$V_{CE} = 400\text{ V}$, $I_C = 10\text{ A}$, $R_G = 10\ \Omega$,	-	20	-	ns
t_r	Current rise time	$V_{GE} = 15\text{ V}$, $T_J = 175\text{ }^\circ\text{C}$		6.8		
$(di/dt)_{on}$	Turn-on current slope	(see Figure 34. Test circuit for inductive load switching and Figure 36. Switching waveform)		1176		A/ μ s
$t_{r(Voff)}$	Off voltage rise time	$V_{CE} = 400\text{ V}$, $I_C = 10\text{ A}$, $R_G = 10\ \Omega$,		19.6		ns
$t_{d(off)}$	Turn-off delay time	$V_{GE} = 15\text{ V}$		103		
t_f	Current fall time	(see Figure 34. Test circuit for inductive load switching and Figure 36. Switching waveform)		73		
$t_{r(Voff)}$	Off voltage rise time	$V_{CE} = 400\text{ V}$, $I_C = 10\text{ A}$, $R_G = 10\ \Omega$,	-	28	-	ns
$t_{d(off)}$	Turn-off delay time	$V_{GE} = 15\text{ V}$, $T_J = 175\text{ }^\circ\text{C}$		104		
t_f	Current fall time	(see Figure 34. Test circuit for inductive load switching and Figure 36. Switching waveform)		110		
t_{sc}	Short-circuit withstand time	$V_{CC} \leq 360\text{ V}$, $V_{GE} = 15\text{ V}$, $R_G = 10\ \Omega$	3	5	-	μ s

Table 6. Switching energy (inductive load)

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
$E_{on}^{(1)}$	Turn-on switching energy	$V_{CE} = 400\text{ V}$, $I_C = 10\text{ A}$, $R_G = 10\ \Omega$,		83		μ J
$E_{off}^{(2)}$	Turn-off switching energy	$V_{GE} = 15\text{ V}$		140		
E_{ts}	Total switching energy	(see Figure 34. Test circuit for inductive load switching)		223		
$E_{on}^{(1)}$	Turn-on switching energy	$V_{CE} = 400\text{ V}$, $I_C = 10\text{ A}$, $R_G = 10\ \Omega$,	-	148	-	μ J
$E_{off}^{(2)}$	Turn-off switching energy	$V_{GE} = 15\text{ V}$, $T_J = 175\text{ }^\circ\text{C}$		214		
E_{ts}	Total switching energy	(see Figure 34. Test circuit for inductive load switching)		362		

1. Including the reverse recovery of the diode.

2. Including the tail of the collector current.

Table 7. Collector-emitter diode

Symbol	Parameter	Test conditions	Min.	Typ.	Max.	Unit
V_F	Forward on-voltage	$I_F = 10\text{ A}$	-	1.7	2.2	V
		$I_F = 10\text{ A}, T_J = 175\text{ °C}$		1.3		
t_{rr}	Reverse recovery time	$V_r = 60\text{ V}; I_F = 10\text{ A}, di_F/dt = 100\text{ A} / \mu\text{s}$ (see Figure 37. Diode reverse recovery waveform)	-	107		ns
Q_{rr}	Reverse recovery charge			120		nC
I_{rrm}	Reverse recovery current			2.24		A
t_{rr}	Reverse recovery time	$V_r = 60\text{ V}; I_F = 10\text{ A}, di_F/dt = 100\text{ A} / \mu\text{s}$	-	161		ns
Q_{rr}	Reverse recovery charge	$T_J = 175\text{ °C}$ (see Figure 37. Diode reverse recovery waveform)		362		nC
I_{rrm}	Reverse recovery current			4.5		A

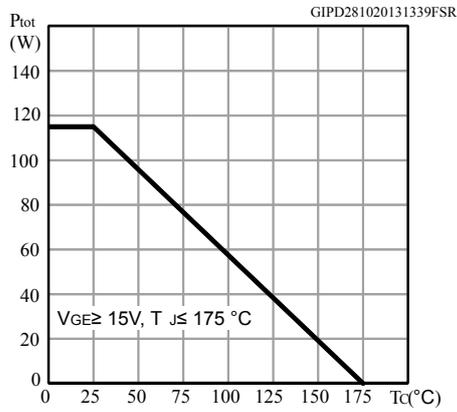
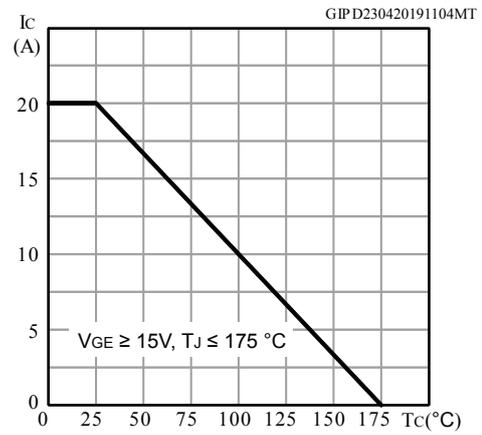
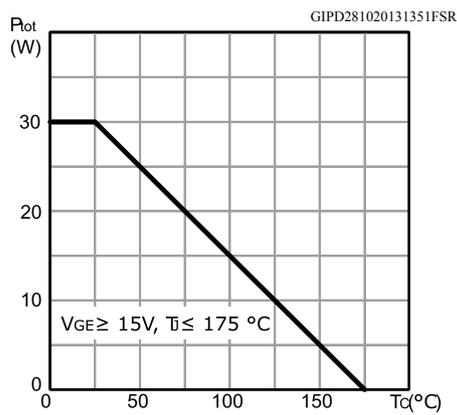
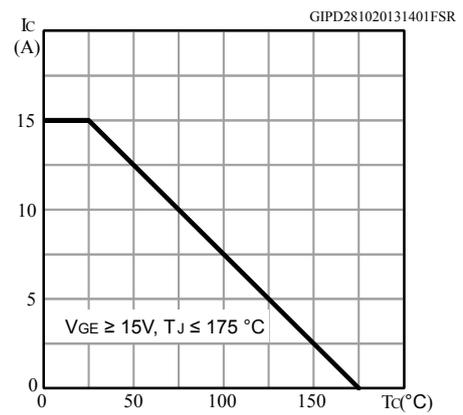
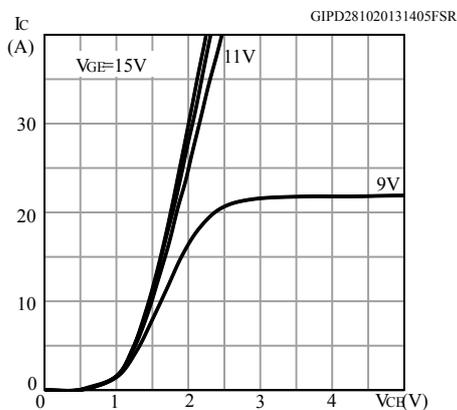
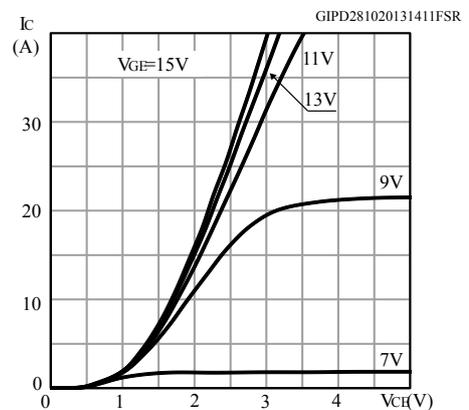
2.1 Electrical characteristics (curves)
Figure 1. Power dissipation vs case temperature for D²PAK and TO-220

Figure 2. Collector current vs case temperature for D²PAK and TO-220

Figure 3. Power dissipation vs case temperature for TO-220FP

Figure 4. Collector current vs case temperature for TO-220FP

Figure 5. Output characteristics ($T_j = 25^\circ C$)

Figure 6. Output characteristics ($T_j = 175^\circ C$)


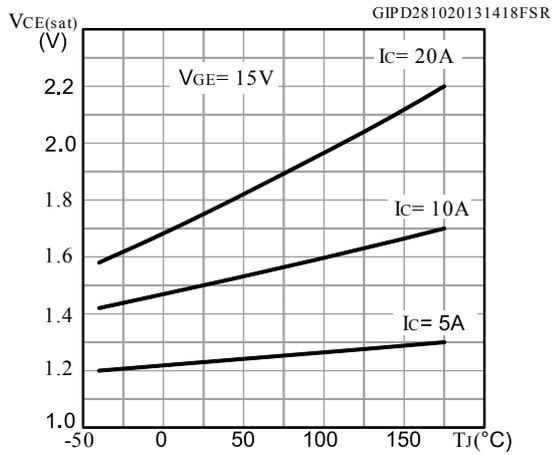
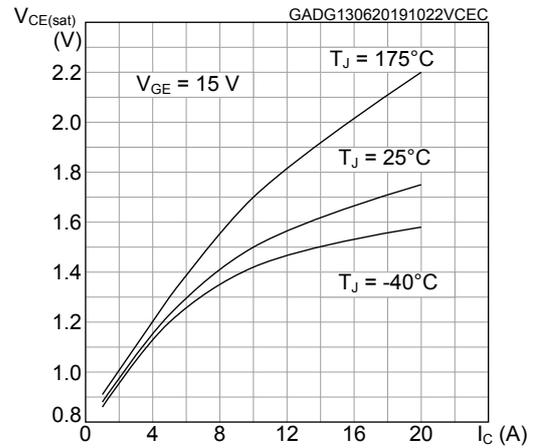
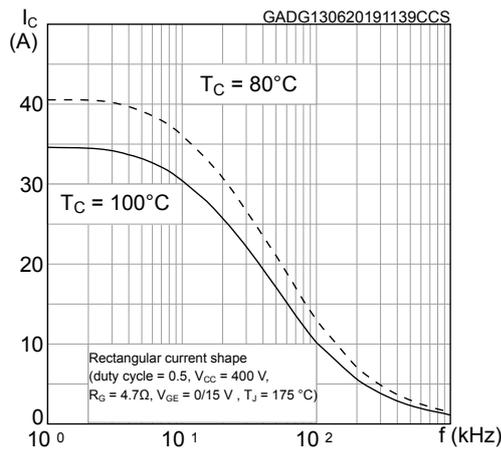
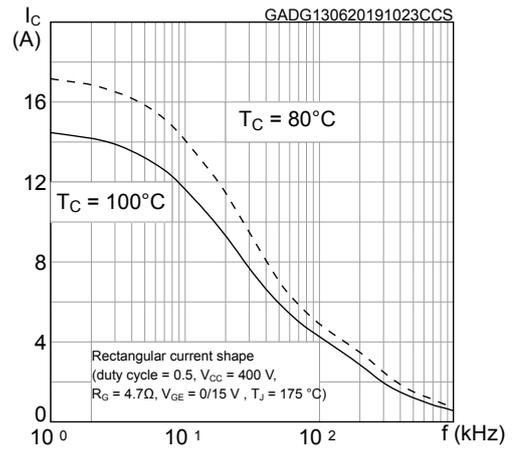
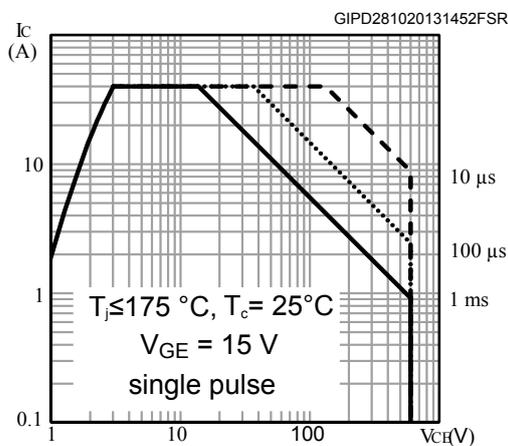
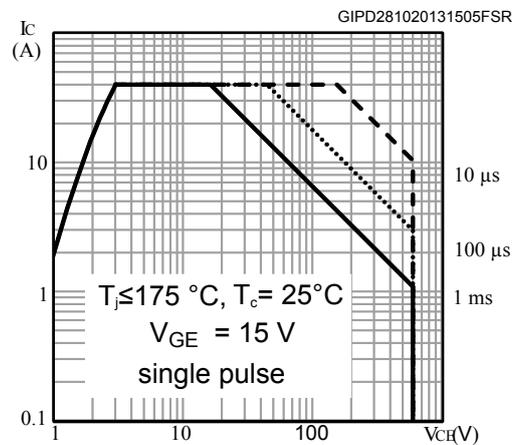
Figure 7. $V_{CE(sat)}$ vs junction temperature

Figure 8. $V_{CE(sat)}$ vs collector current

Figure 9. Collector current vs switching frequency for D²PAK and TO-220

Figure 10. Collector current vs switching frequency for TO-220FP

Figure 11. Forward bias safe operating area for D²PAK and TO-220

Figure 12. Forward bias safe operating area for TO-220FP


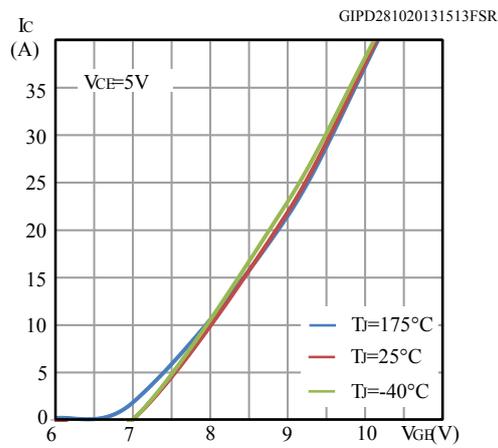
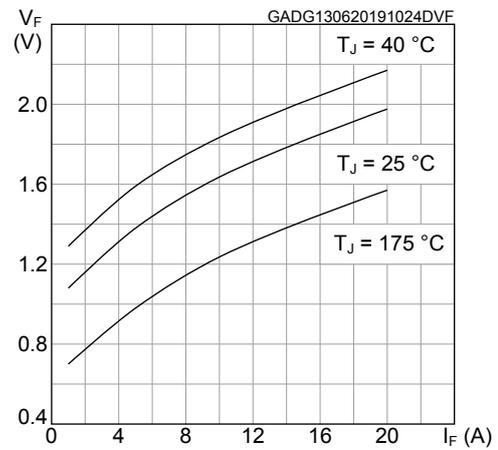
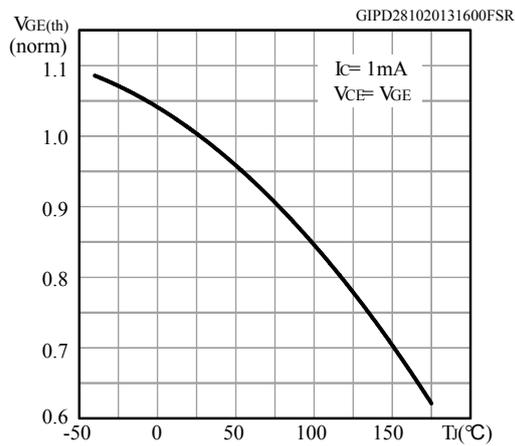
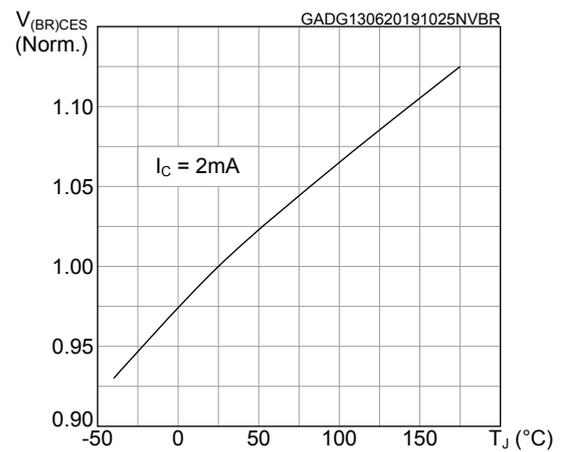
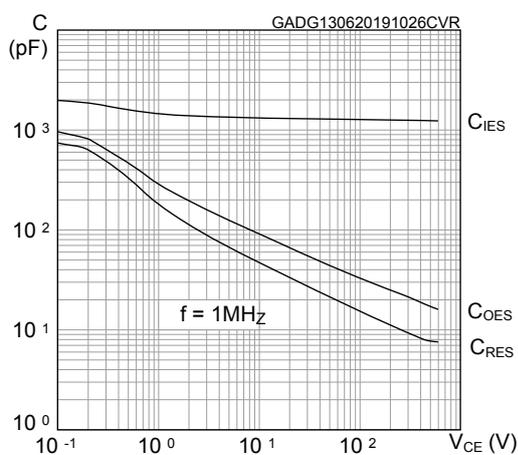
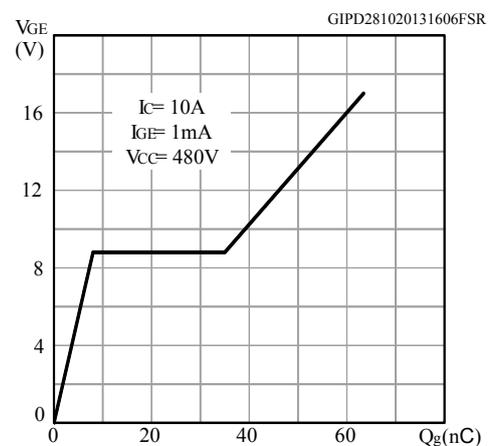
Figure 13. Transfer characteristics

Figure 14. Diode V_F vs forward current

Figure 15. Normalized $V_{GE(th)}$ vs junction temperature

Figure 16. Normalized $V_{(BR)CES}$ vs junction temperature

Figure 17. Capacitance variation

Figure 18. Gate charge vs gate-emitter voltage


Figure 19. Switching energy vs collector current

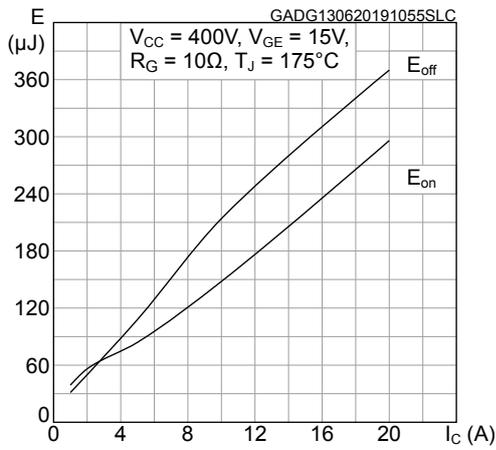


Figure 20. Switching energy vs gate resistance

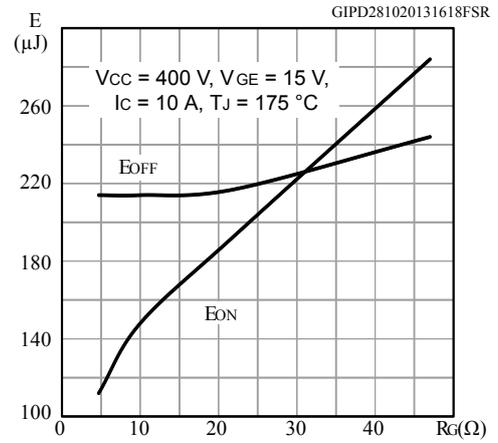


Figure 21. Switching energy vs temperature

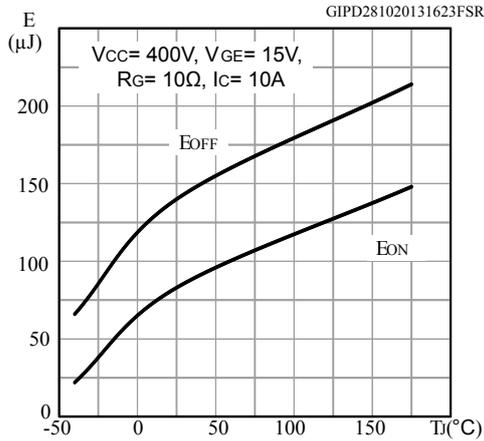


Figure 22. Switching energy vs collector-emitter voltage

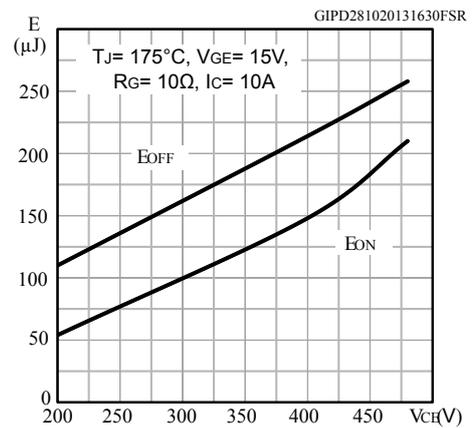


Figure 23. Short circuit time and current vs VGE

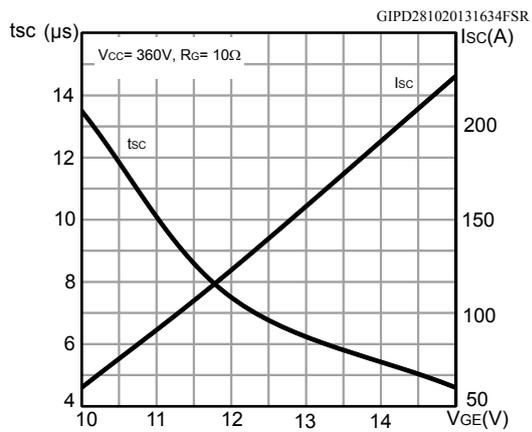


Figure 24. Switching times vs collector current

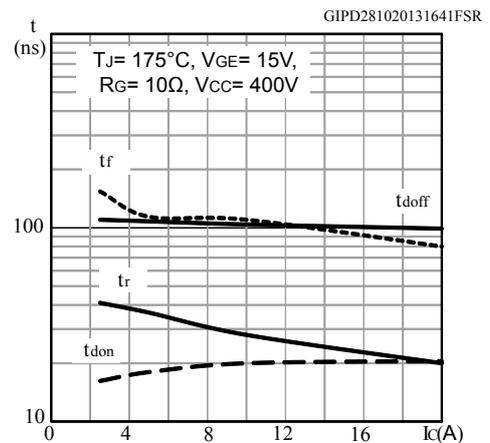


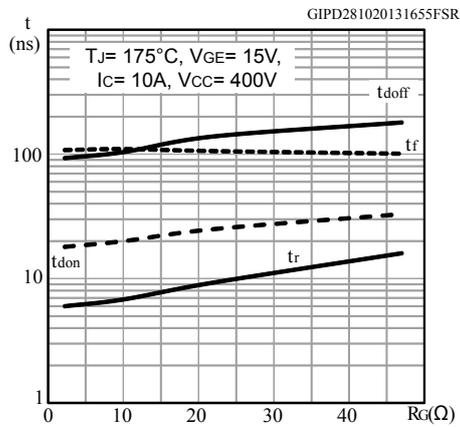
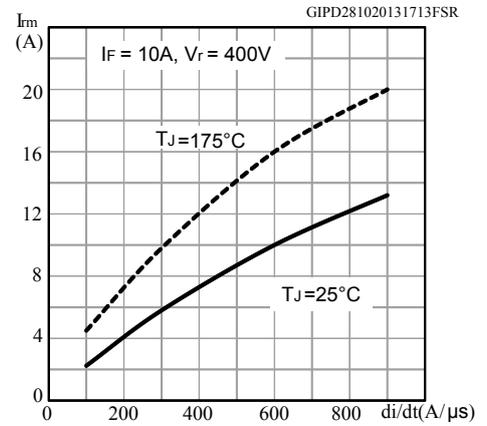
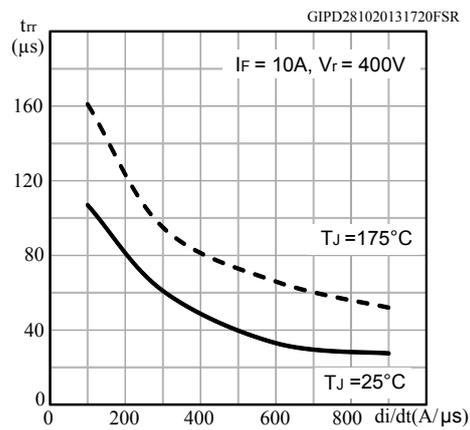
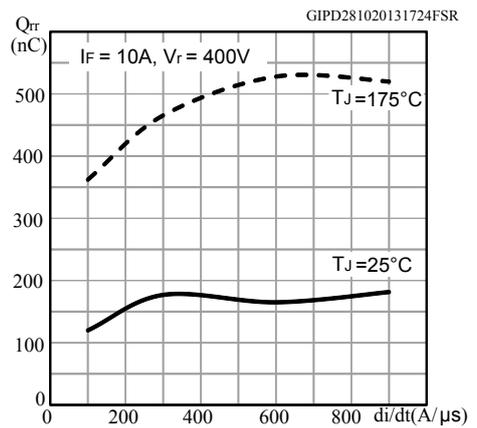
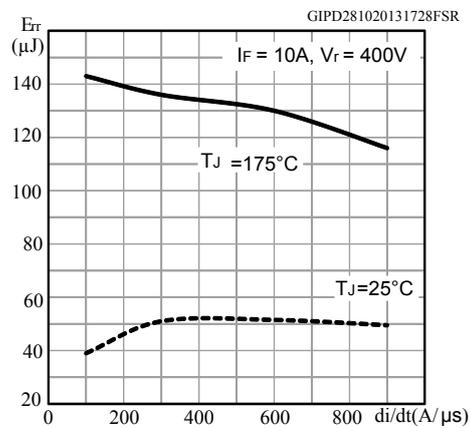
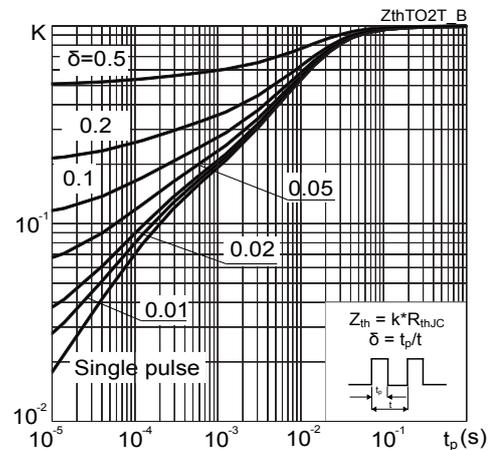
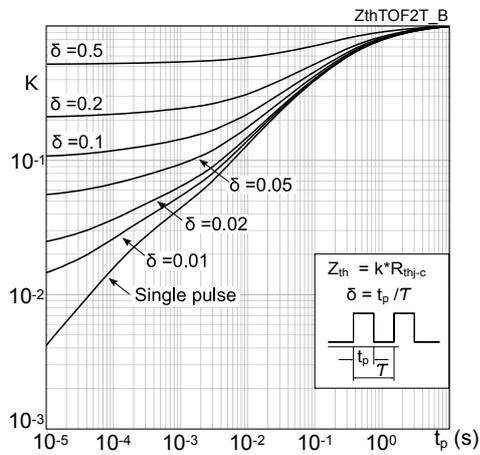
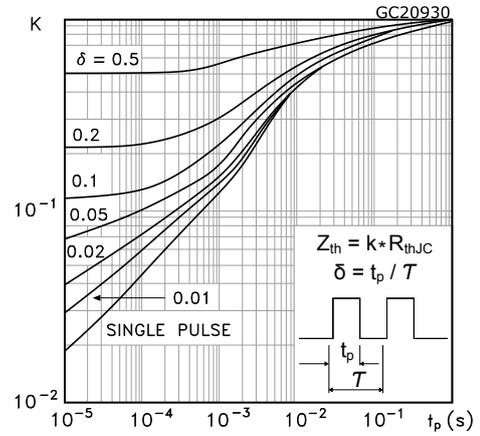
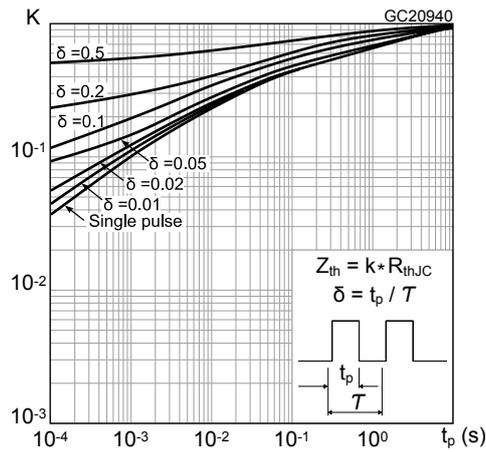
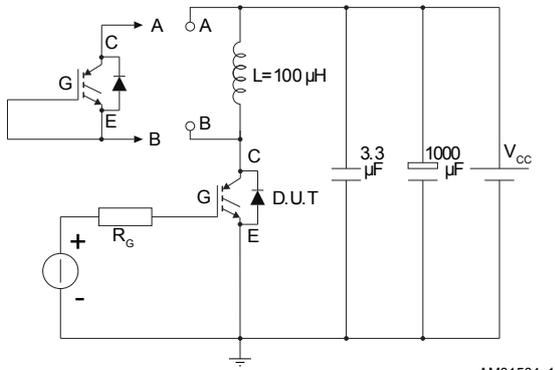
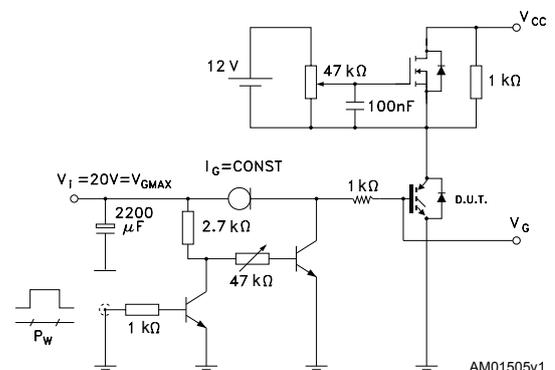
Figure 25. Switching times vs gate resistance

Figure 26. Reverse recovery current vs diode current slope

Figure 27. Reverse recovery time vs diode current slope

Figure 28. Reverse recovery charge vs diode current slope

Figure 29. Reverse recovery energy vs diode current slope

Figure 30. Normalized transient thermal impedance for TO-220 and D²PAK (IGBT)


Figure 31. Normalized transient thermal impedance for TO-220FP (IGBT)

Figure 32. Normalized transient thermal impedance for TO-220 and D²PAK (diode)

Figure 33. Normalized transient thermal impedance for TO-220FP (diode)


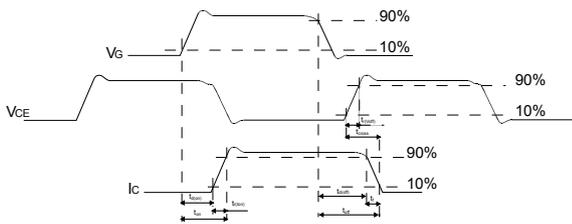
3 Test circuits

Figure 34. Test circuit for inductive load switching


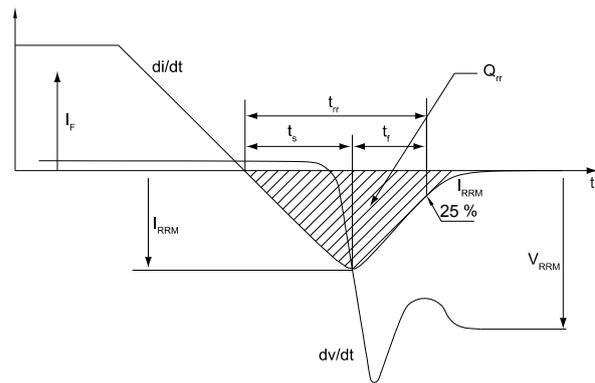
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Figure 35. Gate charge test circuit


AM01505v1

Figure 36. Switching waveform


AM01506v1

Figure 37. Diode reverse recovery waveform


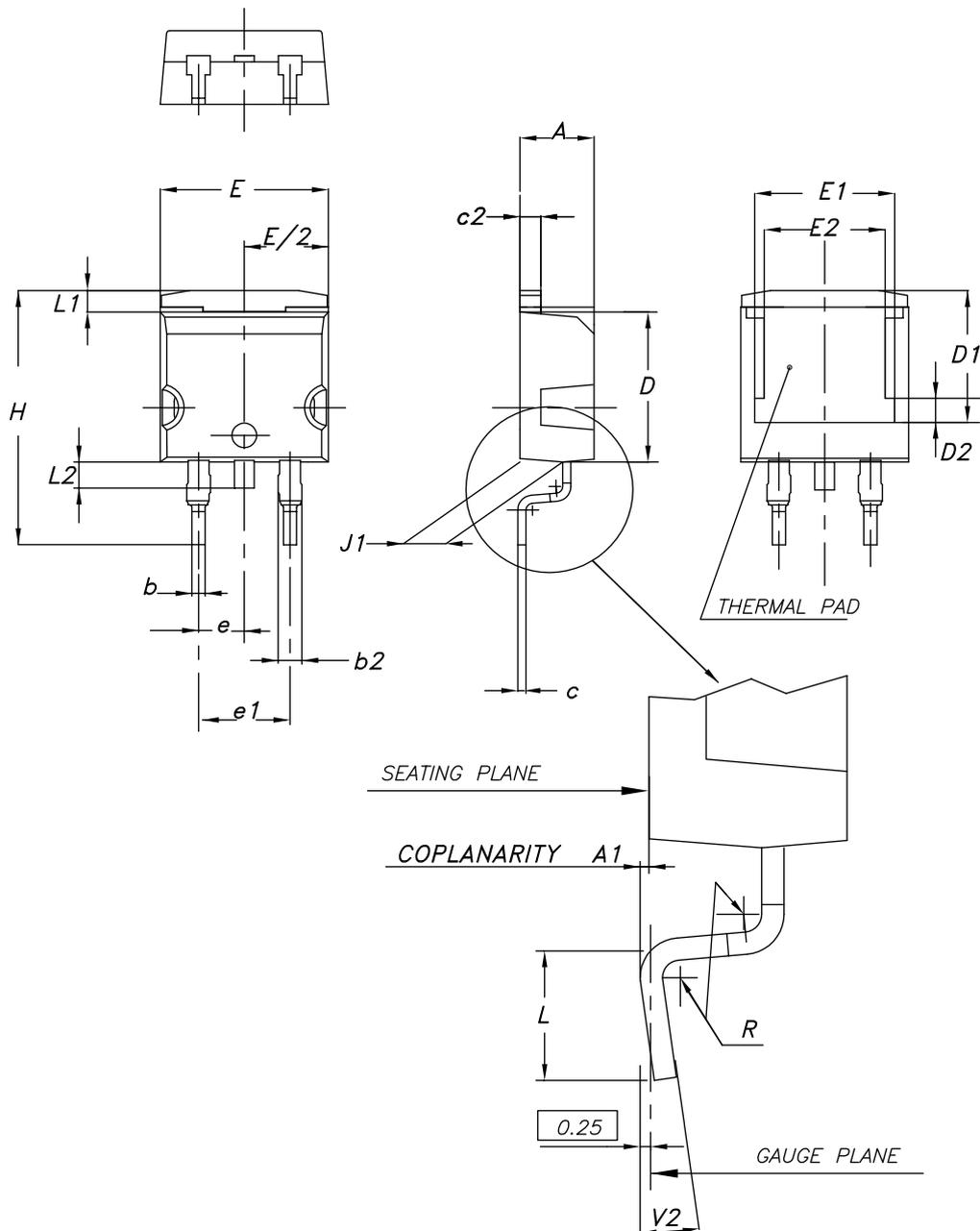
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4 Package information

To meet environmental requirements, ST offers these devices in different grades of **ECOPACK** packages, depending on their level of environmental compliance. ECOPACK specifications, grade definitions, and product status are available at: www.st.com. ECOPACK is an ST trademark.

4.1 D²PAK (TO-263) type A2 package information

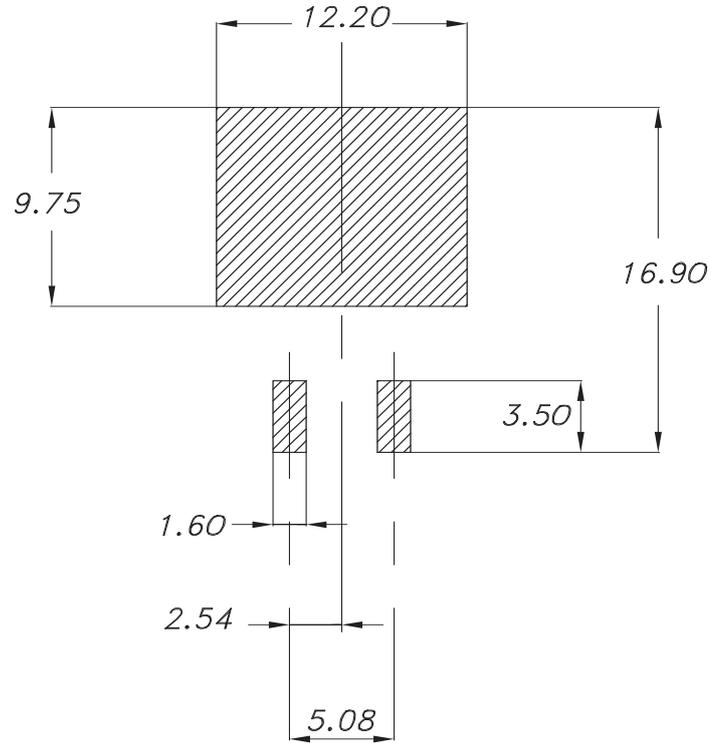
Figure 38. D²PAK (TO-263) type A2 package outline



0079457_A2_27

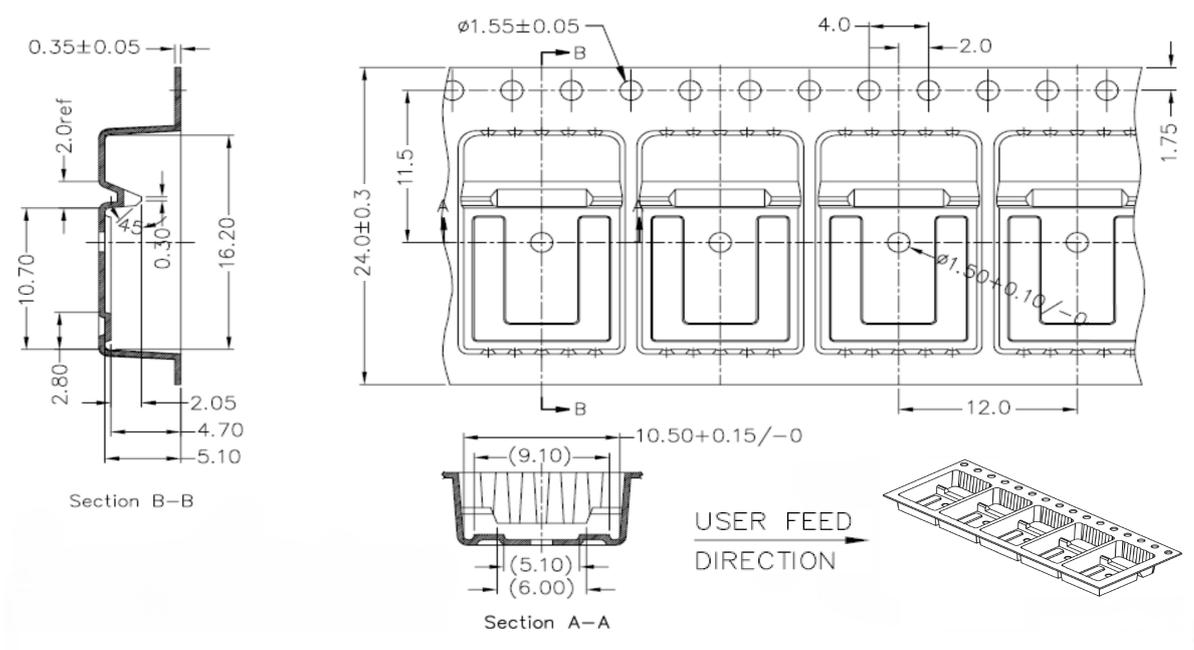
Table 8. D²PAK (TO-263) type A2 package mechanical data

Dim.	mm		
	Min.	Typ.	Max.
A	4.40		4.60
A1	0.03		0.23
b	0.70		0.93
b2	1.14		1.70
c	0.45		0.60
c2	1.23		1.36
D	8.95		9.35
D1	7.50	7.75	8.00
D2	1.10	1.30	1.50
E	10.00		10.40
E1	8.70	8.90	9.10
E2	7.30	7.50	7.70
e		2.54	
e1	4.88		5.28
H	15.00		15.85
J1	2.49		2.69
L	2.29		2.79
L1	1.27		1.40
L2	1.30		1.75
R		0.40	
V2	0°		8°

Figure 39. D²PAK (TO-263) recommended footprint (dimensions are in mm)


0079457_Rev27_footprint

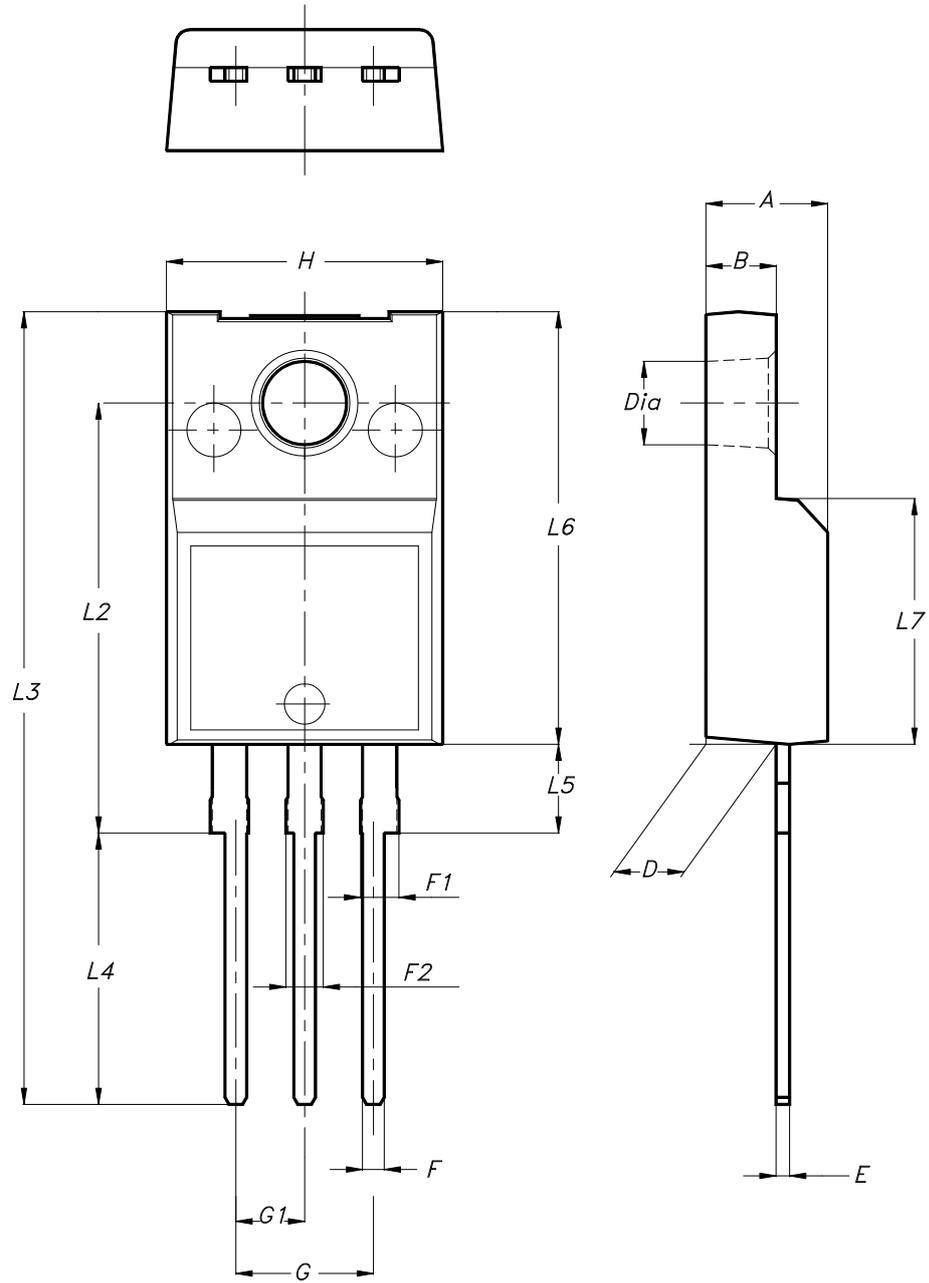
4.2 D²PAK packing information

Figure 40. D²PAK tape drawing


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4.3 TO-220FP type B package information

Figure 41. TO-220FP type B package outline



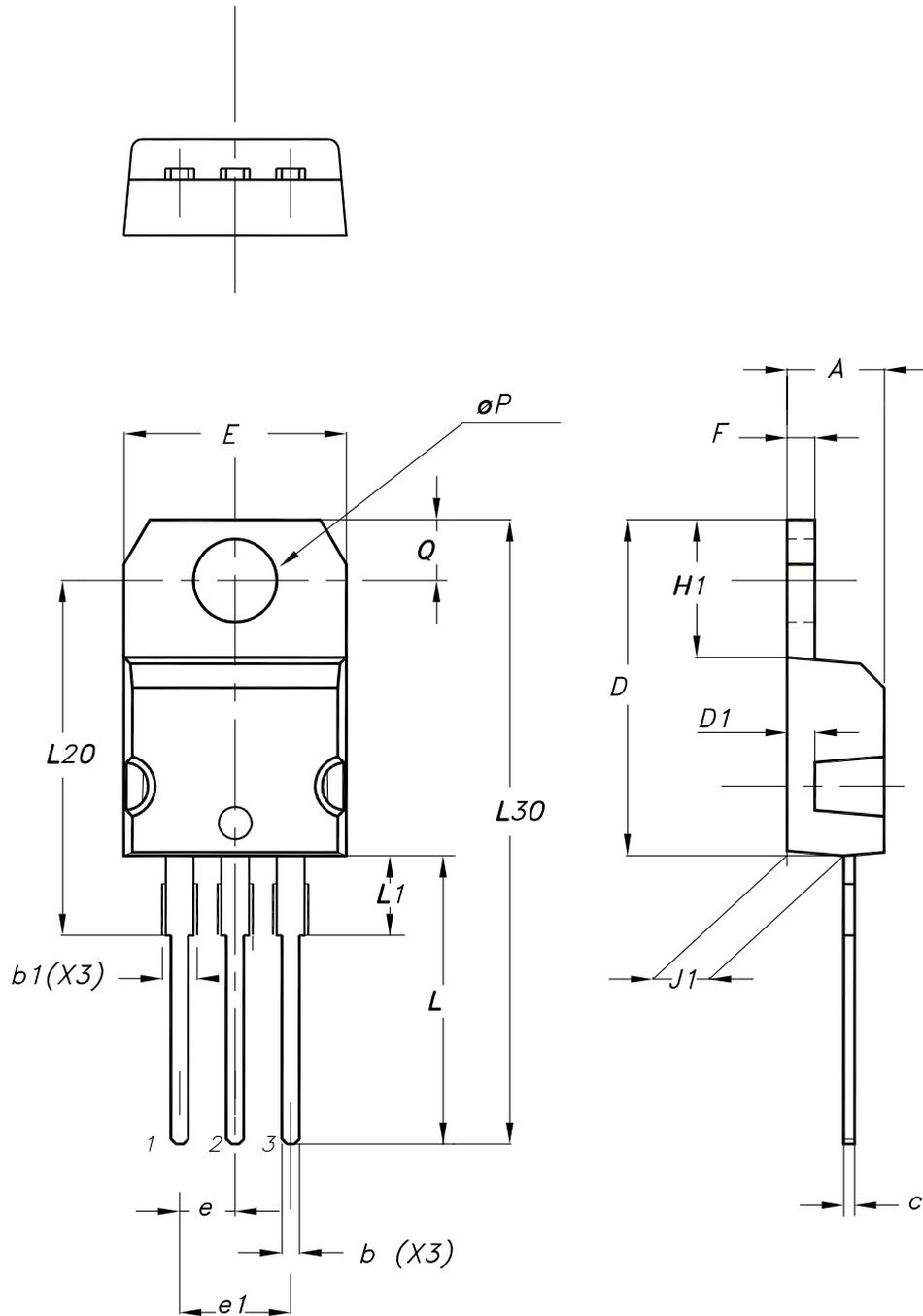
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Table 9. TO-220FP type B package mechanical data

Dim.	mm		
	Min.	Typ.	Max.
A	4.40		4.60
B	2.50		2.70
D	2.50		2.75
E	0.45		0.70
F	0.75		1.00
F1	1.15		1.70
F2	1.15		1.70
G	4.95		5.20
G1	2.40		2.70
H	10.00		10.40
L2		16.00	
L3	28.60		30.60
L4	9.80		10.60
L5	2.90		3.60
L6	15.90		16.40
L7	9.00		9.30
Dia	3.00		3.20

4.4 TO-220 type A package information

Figure 42. TO-220 type A package outline



0015988_typeA_Rev_24

Table 10. TO-220 type A package mechanical data

Dim.	mm		
	Min.	Typ.	Max.
A	4.40		4.60
b	0.61		0.88
b1	1.14		1.55
c	0.48		0.70
D	15.25		15.75
D1		1.27	
E	10.00		10.40
e	2.40		2.70
e1	4.95		5.15
F	1.23		1.32
H1	6.20		6.60
J1	2.40		2.72
L	13.00		14.00
L1	3.50		3.93
L20		16.40	
L30		28.90	
øP	3.75		3.85
Q	2.65		2.95
Slug flatness		0.03	0.10



5 Ordering information

Table 11. Order codes

Order code	Marking	Package	Packing
STGB10H60DF	GB10H60DF	D ² PAK	Tape and reel
STGF10H60DF	GF10H60DF	TO-220FP	Tube
STGP10H60DF	GP10H60DF	TO-220	

Revision history

Table 12. Document revision history

Date	Version	Changes
12-Aug-2013	1	Initial release.
31-Oct-2013	2	Document status promoted from preliminary to production data. Inserted <i>Section 2.1: Electrical characteristics (curves)</i> . Minor text changes.
20-Jun-2019	3	Updated title, applications and description in cover page. Added <i>Section 5 Ordering information</i> . Updated <i>Section 2.1 Electrical characteristics (curves)</i> . Minor text changes.
05-Mar-2020	4	Updated <i>Table 3. Static</i> and <i>Table 4. Dynamic</i> . Minor text changes.
21-Jan-2022	5	Modified <i>Figure 30. Normalized transient thermal impedance for TO-220 and D²PAK (IGBT)</i> and <i>Figure 32. Normalized transient thermal impedance for TO-220 and D²PAK (diode)</i> . Added <i>Figure 31. Normalized transient thermal impedance for TO-220FP (IGBT)</i> and <i>Figure 33. Normalized transient thermal impedance for TO-220FP (diode)</i> . Minor text changes.
17-Apr-2025	6	Updated <i>Section 4: Package information</i> .



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